


General Description

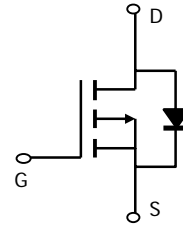
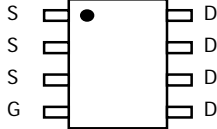
The AO4407A uses advanced trench technology to provide excellent $R_{DS(ON)}$, and ultra-low low gate charge with a 25V gate rating. This device is suitable for use as a load switch or in PWM applications. *Standard Product AO4407A is Pb-free (meets ROHS & Sony 259 specifications).*

Features

$V_{DS} = -30V$
 $I_D = -12A$ ($V_{GS} = -10V$)
 $R_{DS(ON)} < 11m\Omega$ ($V_{GS} = -20V$)
 $R_{DS(ON)} < 13m\Omega$ ($V_{GS} = -10V$)
 $R_{DS(ON)} < 38m\Omega$ ($V_{GS} = -10V$)

UIS TESTED!
RG, CISS, COSS, CRSS TESTED!

SOIC-8
Top View


Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	10 Sec	Steady State	Units
Drain-Source Voltage	V_{DS}	-30		V
Gate-Source Voltage	V_{GS}	± 25		V
Continuous Drain Current ^A	I_D	$T_A=25^\circ C$	-12	A
		$T_A=70^\circ C$	-10	
Pulsed Drain Current ^B	I_{DM}	-60		A
Avalanche Current ^G	I_{AR}	26		
Repetitive avalanche energy $L=0.3mH$ ^G	E_{AR}	101		mJ
Power Dissipation ^A	P_D	$T_A=25^\circ C$	3.1	W
		$T_A=70^\circ C$	2.0	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150		$^\circ C$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	32	40	$^\circ C/W$
Maximum Junction-to-Ambient ^A		Steady State	60	75
Maximum Junction-to-Lead ^C	$R_{\theta JL}$	17	24	$^\circ C/W$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$	-30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -30\text{V}$, $V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			-10 -50	μA
I_{GSS}	Gate-Body leakage current	$V_{DS} = 0\text{V}$, $V_{GS} = \pm 25\text{V}$			± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250\mu\text{A}$	-1.7	-2.3	-3	V
$I_{D(ON)}$	On state drain current	$V_{GS} = -10\text{V}$, $V_{DS} = -5\text{V}$	-60			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = -20\text{V}$, $I_D = -12\text{A}$ $T_J = 125^\circ\text{C}$		8.5	11	m Ω
		$V_{GS} = -10\text{V}$, $I_D = -12\text{A}$		10	13	
		$V_{GS} = -5\text{V}$, $I_D = -10\text{A}$		27	38	
g_{FS}	Forward Transconductance	$V_{DS} = -5\text{V}$, $I_D = -10\text{A}$		21		S
V_{SD}	Diode Forward Voltage	$I_S = -1\text{A}$, $V_{GS} = 0\text{V}$		-0.7	-1	V
I_S	Maximum Body-Diode Continuous Current				-3	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}$, $V_{DS}=-15\text{V}$, $f=1\text{MHz}$		2060	2600	pF
C_{oss}	Output Capacitance			370		pF
C_{rss}	Reverse Transfer Capacitance			295		pF
R_g	Gate resistance	$V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1\text{MHz}$		2.4	3.6	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $I_D=-12\text{A}$		30	39	nC
Q_{gs}	Gate Source Charge			4.6		nC
Q_{gd}	Gate Drain Charge			10		nC
$t_{D(on)}$	Turn-On Delay Time	$V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $R_L=1.25\Omega$, $R_{GEN}=3\Omega$		11		ns
t_r	Turn-On Rise Time			9.4		ns
$t_{D(off)}$	Turn-Off Delay Time			24		ns
t_f	Turn-Off Fall Time			12		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=-12\text{A}$, $di/dt=100\text{A}/\mu\text{s}$		30	40	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-12\text{A}$, $di/dt=100\text{A}/\mu\text{s}$		22		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using $< 300\mu\text{s}$ pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

F: The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

G: E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep $T_J=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

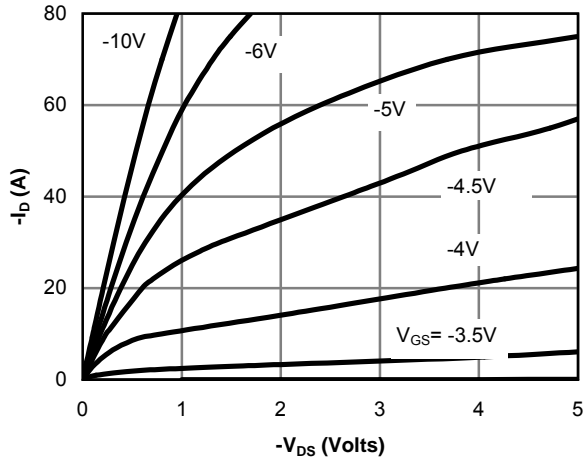


Figure 1: On-Region Characteristics

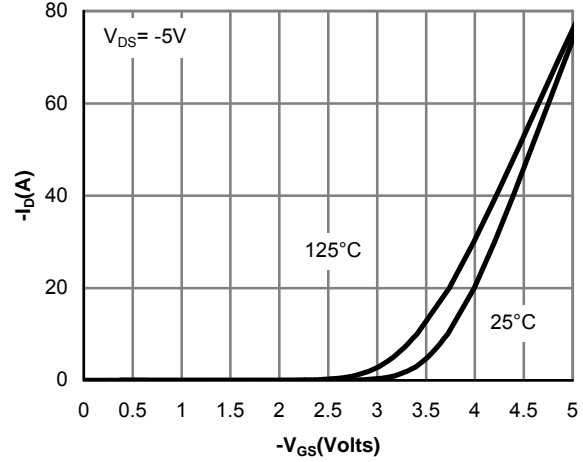


Figure 2: Transfer Characteristics

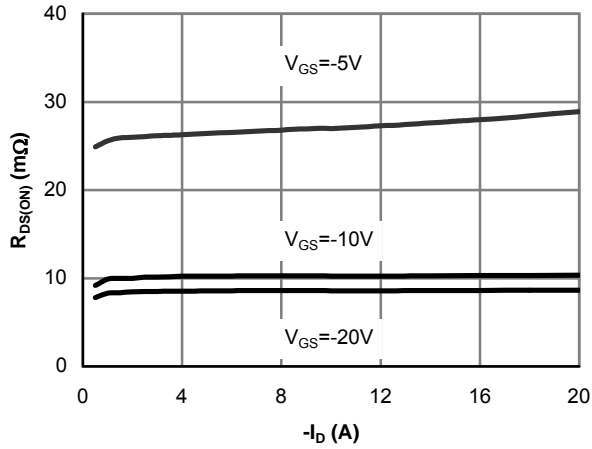


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

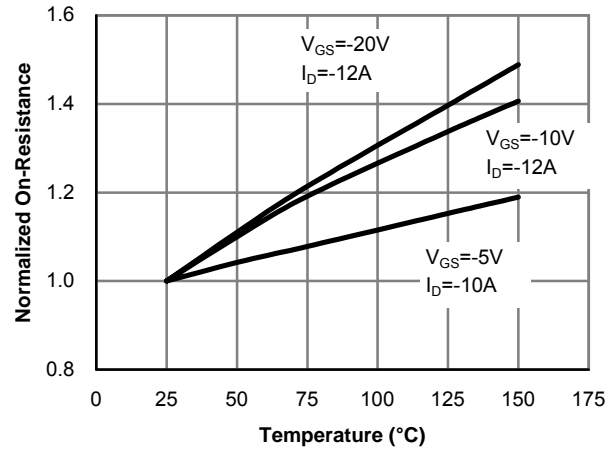


Figure 4: On-Resistance vs. Junction Temperature

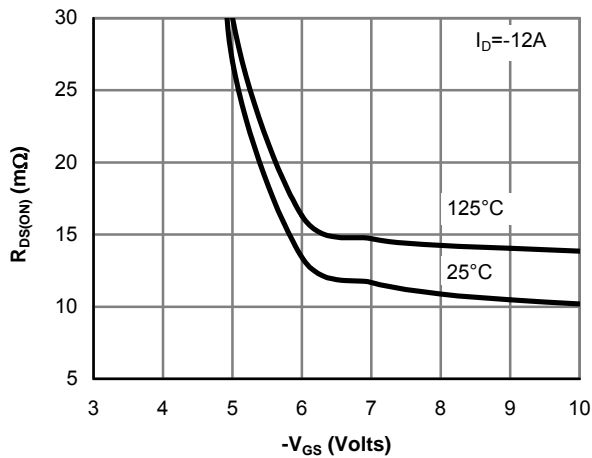


Figure 5: On-Resistance vs. Gate-Source Voltage

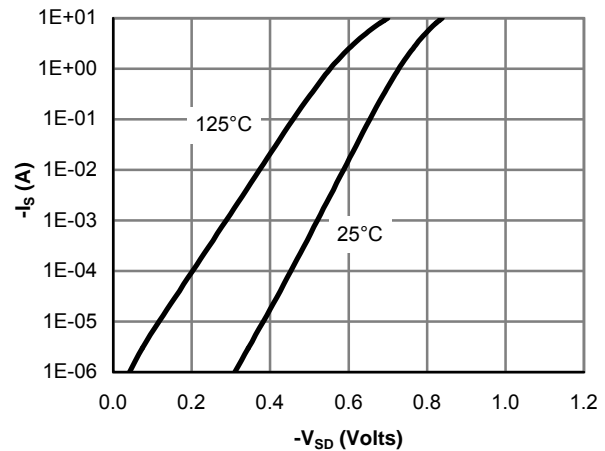


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

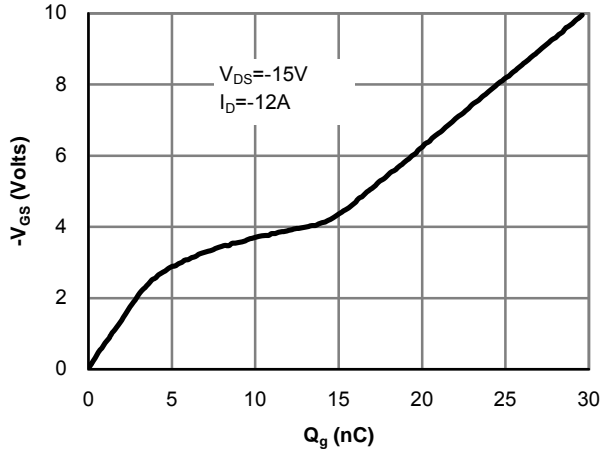


Figure 7: Gate-Charge Characteristics

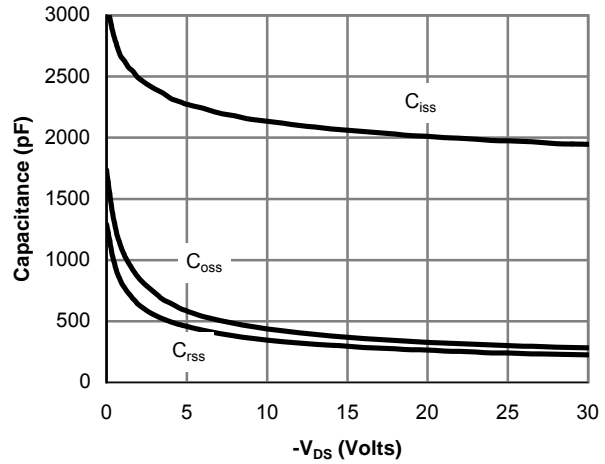


Figure 8: Capacitance Characteristics

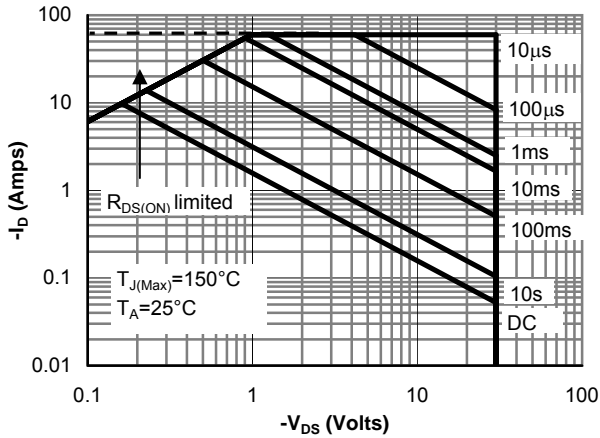


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

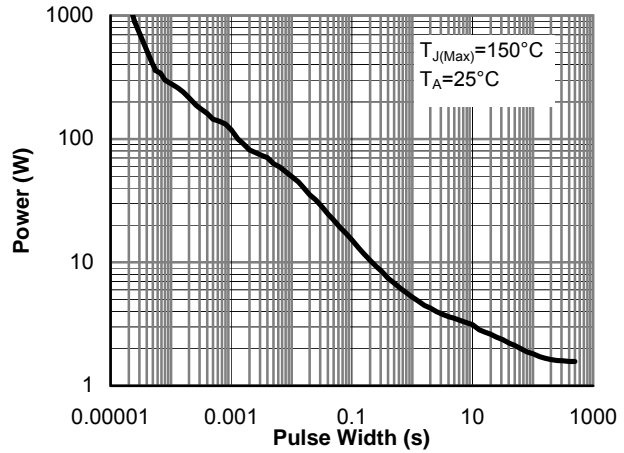


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

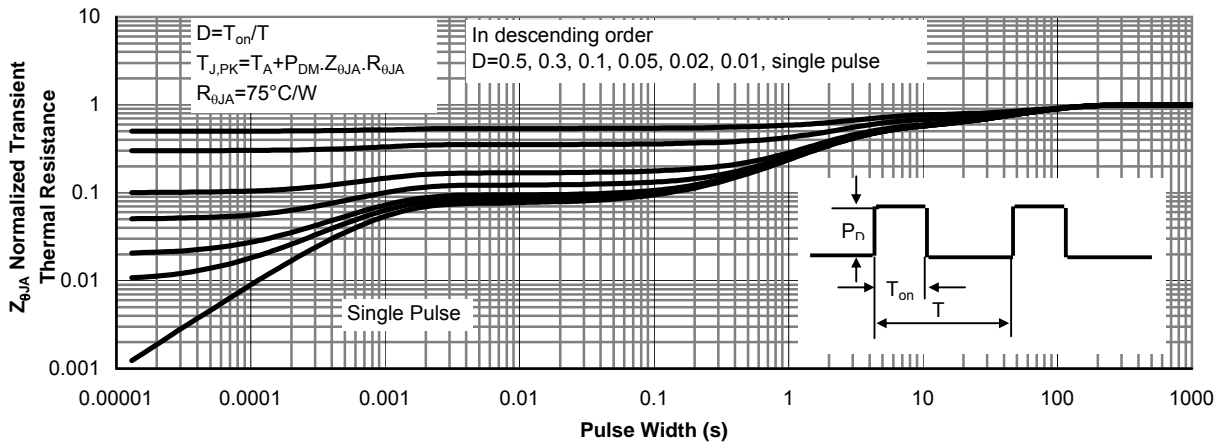


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)